

TOSHIBA CMOS DIGITAL INTEGRATED CIRCUIT SILICON MONOLITHIC

TC74ACT299P, TC74ACT299F, TC74ACT299FW

8-BIT PIPO SHIFT REGISTER WITH ASYNCHRONOUS CLEAR

(Note) The JEDEC SOP (FW) is not available in Japan.

The TC74ACT299 is an advanced high speed CMOS 8-BIT PIPO SHIFT REGISTER fabricated with silicon gate and double-layer metal wiring C²MOS technology.

It achieves the high speed operation similar to equivalent Bipolar Schottky TTL while maintaining the CMOS low power dissipation.

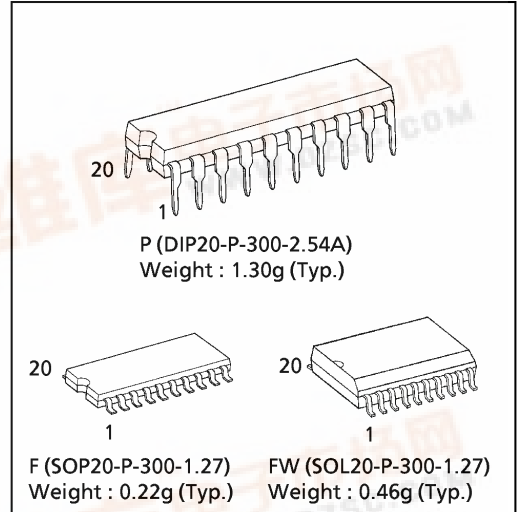
This device may be used as a level converter for interfacing TTL or NMOS to High Speed CMOS. The inputs are compatible with TTL, NMOS and CMOS output voltage levels.

It has a four modes (HOLD, SHIFT LEFT, SHIFT RIGHT and LOAD DATA) controlled by the two selection inputs (S0, S1).

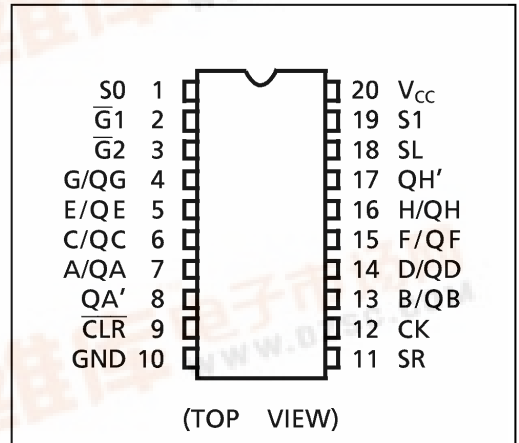
When one or both enable ($\overline{G1}$, $\overline{G2}$) are high, the eight I/O outputs are forced to the high-impedance state; however, sequential operation or clearing of the register is not affected. All inputs are equipped with protection circuits against static discharge or transient excess voltage.

FEATURES:

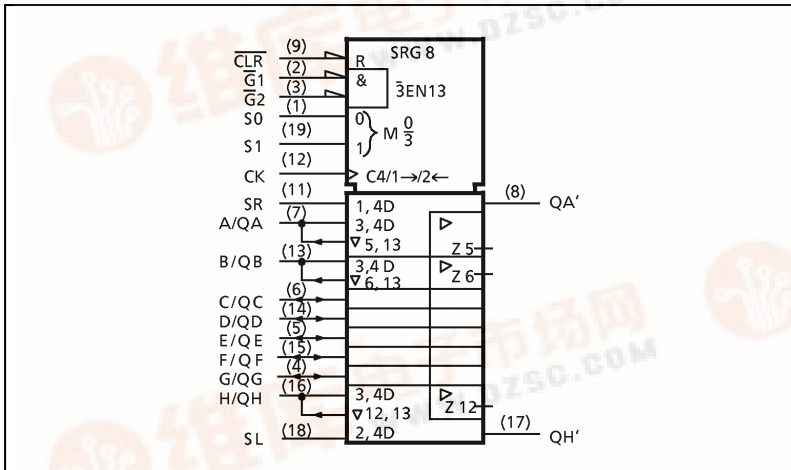
- High Speed..... $f_{MAX} = 130\text{MHz}$ (typ.)
at $V_{CC} = 5\text{V}$
- Low Power Dissipation..... $I_{CC} = 8\mu\text{A}$ (Max.) at $T_a = 25^\circ\text{C}$
- Compaible with TTL outputs $V_{IL} = 0.8\text{V}$ (Max.)
 $V_{IH} = 2.0\text{V}$ (Min.)
- Symmetrical Output Impedance... $|I_{OH}| = I_{OL} = 24\text{mA}$ (Min.)
Capability of driving 50Ω transmission lines.
- Balanced Propagation Delays..... $t_{pLH} \approx t_{pHL}$
- Pin and Function Compatible with 74F299



PIN ASSIGNMENT



IEC LOGIC SYMBOL



APPLICATION NOTES

- 1) Do not apply a signal to any bus terminal when it is in the output mode. Damage may result.
- 2) All floating (high impedance) bus terminals must have their input levels fixed by means of pull up or pull down resistors.

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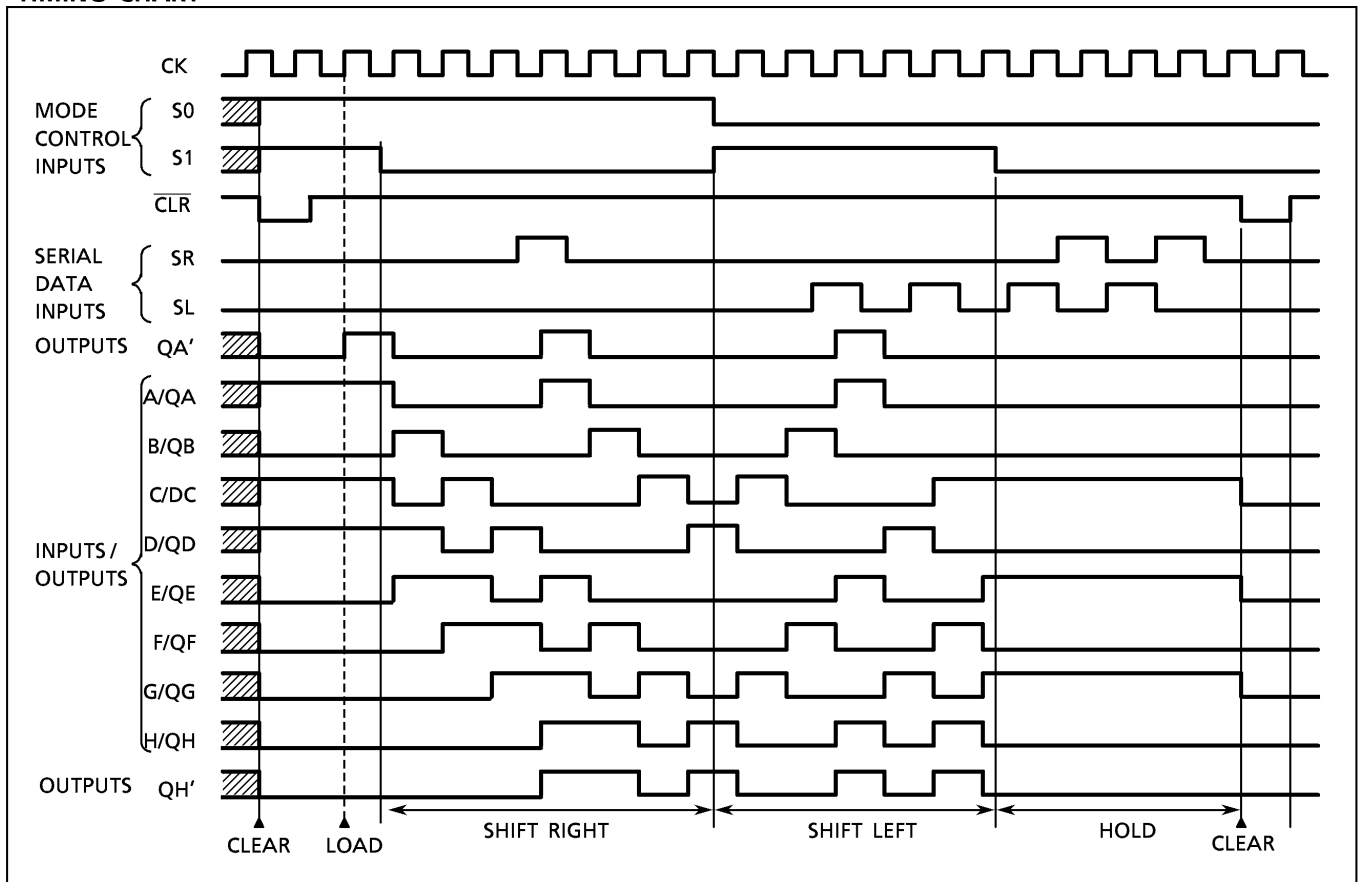
TRUTH TABLE

| MODE | INPUTS | | | | | | | | INPUTS/OUTPUTS | | OUTPUTS | |
|-------|-------------------------|-----------------|----|--------------------------|--------------------------|------------|--------|----|----------------|------|---------|-----|
| | $\overline{\text{CLR}}$ | FUNCTION SELECT | | OUTPUT CONTROL | | CK | SERIAL | | A/QA | H/QH | QA' | QH' |
| | | S1 | S0 | $\overline{\text{G1}}^*$ | $\overline{\text{G2}}^*$ | | SL | SR | | | | |
| Z | L | H | H | X | X | X | X | X | Z | Z | L | L |
| CLEAR | L | L | X | L | L | X | X | X | L | L | L | L |
| | L | X | L | L | L | X | X | X | L | L | L | L |
| HOLD | H | L | L | L | L | X | X | X | QA0 | QH0 | QA0 | QH0 |
| SHIFT | H | L | H | L | L | \uparrow | X | H | H | QGn | H | QGn |
| RIGHT | H | L | H | L | L | \uparrow | X | L | L | QGn | L | QGn |
| SHIFT | H | H | L | L | L | \uparrow | H | X | QBn | H | QBn | H |
| LEFT | H | H | L | L | L | \uparrow | L | X | QBn | L | QBn | L |
| LOAD | H | H | H | X | X | \uparrow | X | X | a | h | a | h |

* When one or both output controls are high, the eight input/output terminals are in the high-impedance state; however sequential or clearing of the register is not affected.

Z : High Impedance
 Qn0 : The level of Qn before the indicated steady - state input conditions were established.
 Qnn : The level of Qn before the most recent active transition indicated by \downarrow or \uparrow .
 a, h : The level of the steady - state inputs A, H, respectively.
 X : Don't Care.

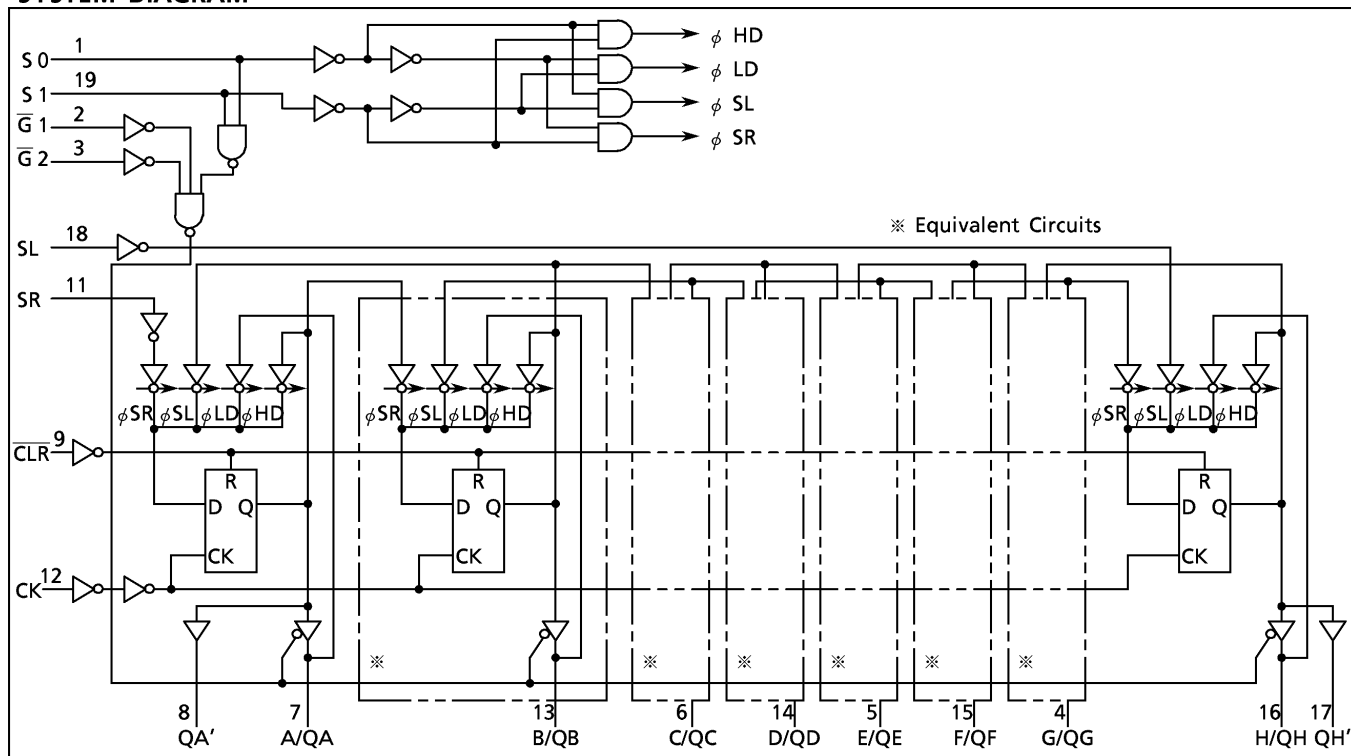
TIMING CHART



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SYSTEM DIAGRAM



ABSOLUTE MAXIMUM RATINGS

| PARAMETER | SYMBOL | VALUE | UNIT |
|-----------------------------|-----------|------------------------|-------------|
| Supply Voltage Range | V_{CC} | -0.5~7.0 | V |
| DC Input Voltage | V_{IN} | -0.5~ $V_{CC} + 0.5$ | V |
| DC Output Voltage | V_{OUT} | -0.5~ $V_{CC} + 0.5$ | V |
| Input Diode Current | I_{IK} | ± 20 | mA |
| Output Diode Current | I_{OK} | ± 50 | mA |
| DC Output Current | I_{OUT} | ± 50 | mA |
| DC V_{CC} /Ground Current | I_{CC} | ± 250 | mA |
| Power Dissipation | P_D | 500 (DIP)* / 180 (SOP) | mW |
| Storage Temperature | T_{stg} | -65~150 | $^{\circ}C$ |

*500mW in the range of $T_a = -40^{\circ}C \sim 65^{\circ}C$. From $T_a = 65^{\circ}C$ to $85^{\circ}C$ a derating factor of $-10mW/^{\circ}C$ should be applied up to 300mW.

RECOMMENDED OPERATING CONDITIONS

| PARAMETER | SYMBOL | VALUE | UNIT |
|--------------------------|-----------|-------------|-------------|
| Supply Voltage | V_{CC} | 4.5~5.5 | V |
| Input Voltage | V_{IN} | 0~ V_{CC} | V |
| Output Voltage | V_{OUT} | 0~ V_{CC} | V |
| Operating Temperature | T_{opr} | -40~85 | $^{\circ}C$ |
| Input Rise and Fall Time | dt/dV | 0~10 | ns/V |

DC ELECTRICAL CHARACTERISTICS

| PARAMETER | SYMBOL | TEST CONDITION | V _{CC} (V) | Ta = 25°C | | | Ta = -40~85°C | | UNIT |
|--------------------------------------|-----------------|--|---------------------|------------------|---------------|------------------|---------------------|---------------------|------|
| | | | | MIN. | TYP. | MAX. | MIN. | MAX. | |
| High - Level Input Voltage | V _{IH} | | 4.5 5.5 | 2.0 | — | — | 2.0 | — | V |
| Low - Level Input Voltage | V _{IL} | | 4.5 5.5 | — | — | 0.8 | — | 0.8 | V |
| High - Level Output Voltage | V _{OH} | V _{IN} = V _{IH} or V _{IL} I _{OH} = -50μA I _{OH} = -24mA I _{OH} = -75mA* | 4.5 4.5 5.5 | 4.4 3.94 — | 4.5 — — | — — — | 4.4 3.80 3.85 | — — — | V |
| Low - Level Output Voltage | V _{OL} | V _{IN} = V _{IH} or V _{IL} I _{OL} = 50μA I _{OL} = 24mA I _{OL} = 75mA* | 4.5 4.5 5.5 | — — — | 0.0 — — | 0.1 0.36 — | — — — | 0.1 0.44 1.65 | V |
| 3 - State Output Off - State Current | I _{OZ} | V _{IN} = V _{IH} or V _{IL} V _{OUT} = V _{CC} or GND | 5.5 | — | — | ± 0.5 | — | ± 5.0 | μA |
| Input Leakage Current | I _{IN} | V _{IN} = V _{CC} or GND | 5.5 | — | — | ± 0.1 | — | ± 1.0 | |
| Quiescent Supply Current | I _{CC} | V _{IN} = V _{CC} or GND | 5.5 | — | — | 8.0 | — | 80.0 | mA |
| | I _C | PER INPUT: V _{IN} = 3.4V OTHER INPUT: V _{CC} or GND | 5.5 | — | — | 1.35 | — | 1.5 | |

* : This spec indicates the capability of driving 50Ω transmission lines.
One output should be tested at a time for a 10ms maximum duration.

TIMING REQUIREMENTS (Input t_r = t_f = 3ns)

| PARAMETER | SYMBOL | TEST CONDITION | V _{CC} (V) | Ta = 25°C | Ta = -40~85°C | UNIT |
|-------------------------------------|--|----------------|---------------------|-----------|---------------|------|
| | | | | LIMIT | LIMIT | |
| Minimum Pulse Width (CK) | t _{w(L)} t _{w(H)} | | 5.0 ± 0.5 | 5.0 | 5.0 | ns |
| Minimum Pulse Width (CLR) | t _{w(L)} | | 5.0 ± 0.5 | 5.0 | 5.0 | |
| Minimum Set - up Time (SL, SR, A~H) | t _s | | 5.0 ± 0.5 | 3.5 | 3.5 | |
| Minimum Set - up Time (S0, S1) | t _s | | 5.0 ± 0.5 | 6.0 | 6.5 | |
| Minimum Hold Time (SL, SR, A~H) | t _h | | 5.0 ± 0.5 | 2.0 | 2.0 | |
| Minimum Hold Time (S0, S1) | t _h | | 5.0 ± 0.5 | 0.0 | 0.0 | |
| Minimum Removal Time (CLR) | t _{rem} | | 5.0 ± 0.5 | 2.0 | 2.0 | |

AC ELECTRICAL CHARACTERISTICS ($C_L = 50\text{pF}$, $R_L = 500\Omega$, $t_r = t_f = 3\text{ns}$)

| PARAMETER | SYMBOL | TEST CONDITION | Ta = 25°C | | | Ta = -40~85°C | | UNIT | |
|--|--------------------------------------|----------------|---------------------|------|------|---------------|------|------|------|
| | | | V _{CC} (V) | MIN. | TYP. | MAX. | MIN. | | MAX. |
| Propagation Delay Time (CK-QA', QH') | t _{pLH} t _{pHL} | | 5.0 ± 0.5 | — | 7.2 | 10.5 | 1.0 | 12.0 | ns |
| Propagation Delay Time ($\overline{\text{CLR}}$ -QA', QH') | t _{pHL} | | 5.0 ± 0.5 | — | 6.0 | 10.0 | 1.0 | 11.5 | |
| Propagation Delay Time (CK-QA~QH) | t _{pLH} t _{pHL} | | 5.0 ± 0.5 | — | 7.4 | 11.4 | 1.0 | 13.0 | |
| Propagation Delay Time ($\overline{\text{CLR}}$ -QA~QH) | t _{pHL} | | 5.0 ± 0.5 | — | 6.3 | 10.5 | 1.0 | 12.0 | |
| Output Enable Time | t _{pZL} t _{pZH} | | 5.0 ± 0.5 | — | 7.4 | 11.4 | 1.0 | 13.0 | |
| Output Disable Time | t _{pLZ} t _{pHZ} | | 5.0 ± 0.5 | — | 7.2 | 9.6 | 1.0 | 11.0 | |
| Maximum Clock Frequency | f _{MAX} | | 5.0 ± 0.5 | 80 | 120 | — | 80 | — | MHz |
| Input Capacitance | C _{IN} | | | — | 5 | 10 | — | 10 | pF |
| Bus Input Capacitance | C _{I/O} | | | — | 13 | — | — | — | |
| Power Dissipation Capacitance | C _{PD} (1) | | | — | 160 | — | — | — | |

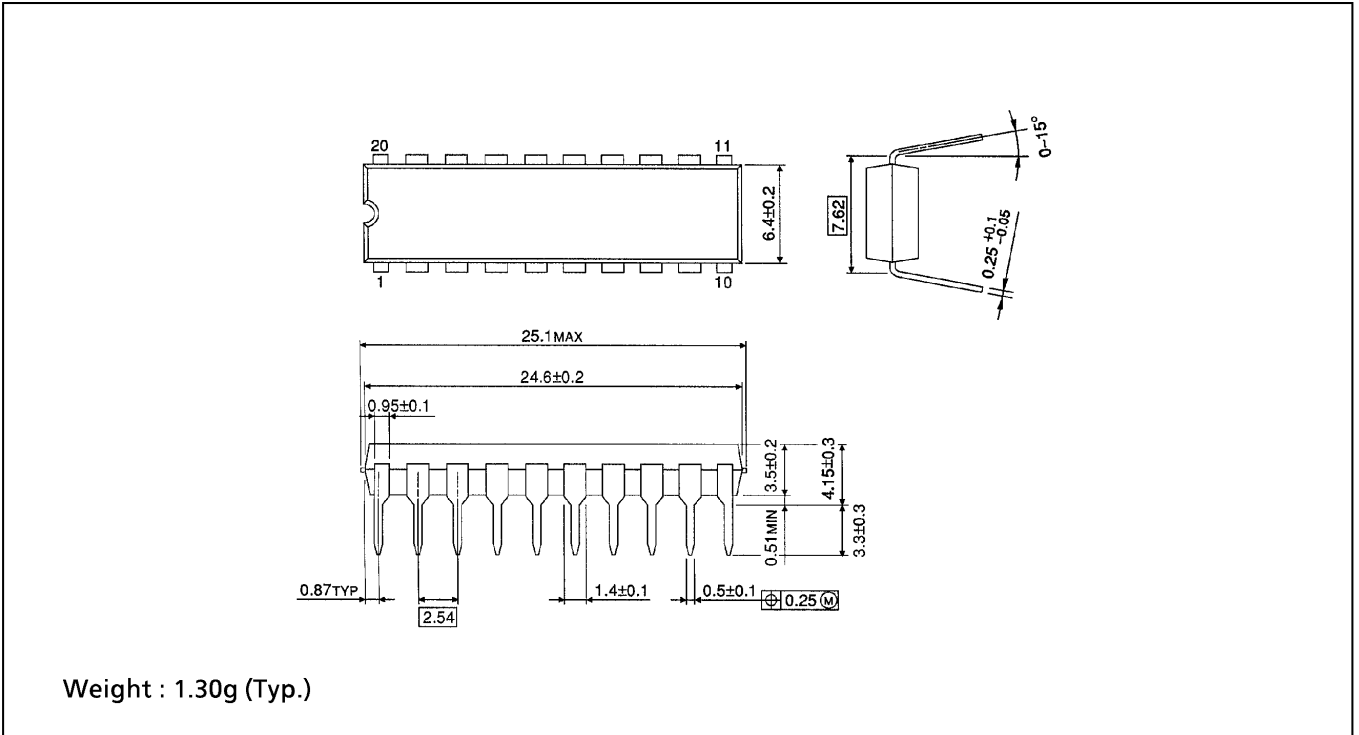
Note (1) C_{PD} is defined as the value of the internal equivalent capacitance which is calculated from the operating current consumption without load.

Average operating current can be obtained by the equation:

$$I_{CC}(\text{opr}) = C_{PD} \cdot V_{CC} \cdot f_{IN} + I_{CC}$$

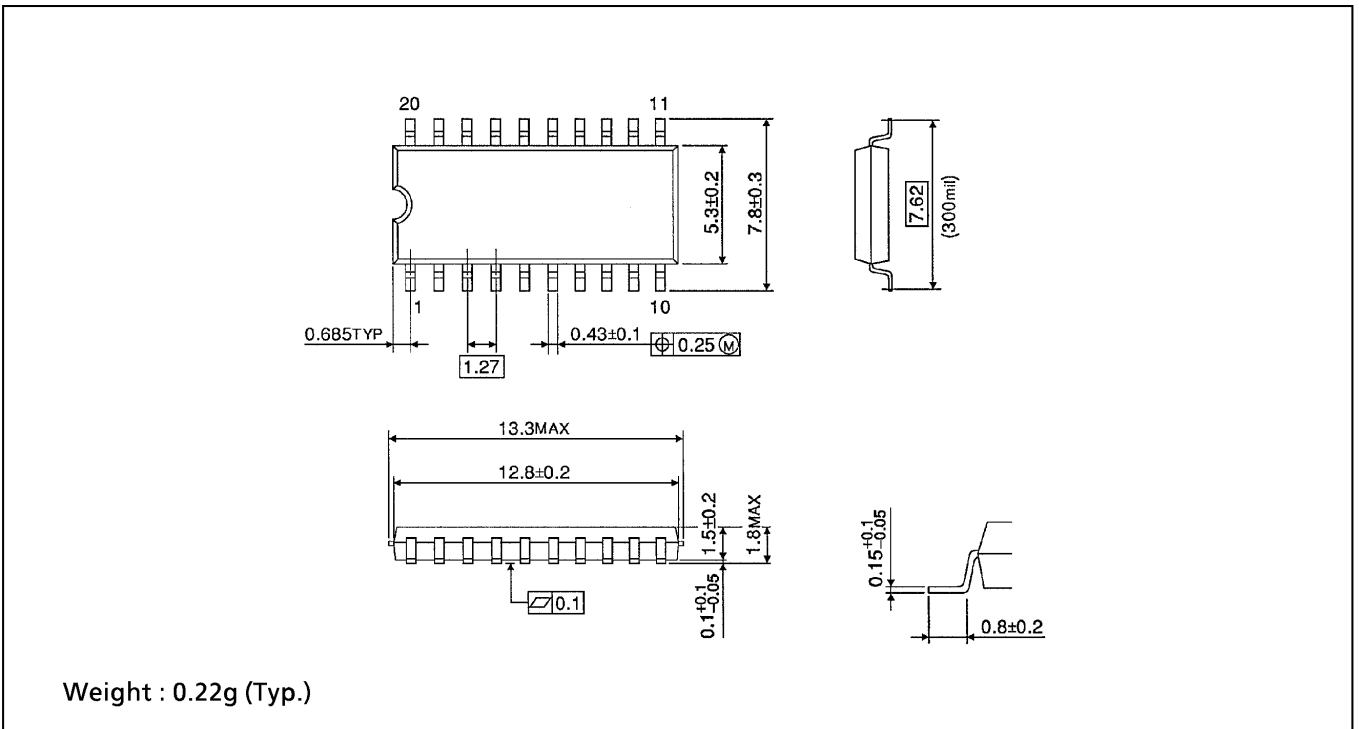
DIP 20PIN OUTLINE DRAWING (DIP20-P-300-2.54A)

Unit in mm



SOP 20PIN (200mil BODY) OUTLINE DRAWING (SOP20-P-300-1.27)

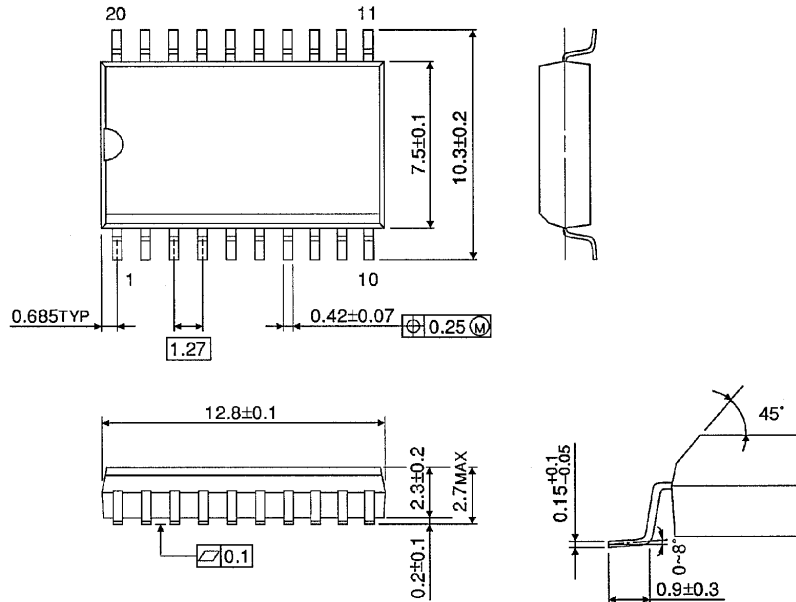
Unit in mm



SOP 20PIN (300mil BODY) OUTLINE DRAWING (SOL20-P-300-1.27)

Unit in mm

(Note) This package is not available in Japan.



Weight : 0.46g (Typ.)